74LVT16543A

3.3 V 16-bit registered transceiver; 3-state

Rev. 4 — 1 April 2021 Product data sheet

1. General description

The 74LVT16543A is a 16-bit registered transceiver with 3-state outputs. The device can be used as two 8-bit transceivers or one 16-bit transceiver.

Data flow in each direction is controlled by intput enable ($n\overline{EAB}$ and $n\overline{EBA}$), latch enable ($n\overline{LEAB}$ and $n\overline{LEBA}$), and output enable ($n\overline{OEAB}$ and $n\overline{OEBA}$) inputs. For A to B data flow, the device operates in the transparent mode when ($n\overline{EAB}$) and ($n\overline{LEAB}$) are LOW. A subsequent LOW-to-HIGH transition of the $n\overline{LEAB}$ input latches the data and the outputs no longer change with the inputs. A HIGH on either $n\overline{EAB}$ or $n\overline{OEAB}$ causes the outputs to assume a high-impedance OFF-state.

Control of data flow from B to A is similar, but using the $n\overline{EBA}$, $n\overline{LEBA}$, and $n\overline{OEBA}$ inputs. Bus hold data inputs eliminate the need for external pull-up resistors to define unused inputs

2. Features and benefits

- 16-bit universal bus interface
- 3-state buffers
- Wide supply voltage range from 2.7 to 3.6 V
- Input and output interface capability to systems at 5 V supply
- Overvoltage tolerant inputs to 5.5 V
- Direct interface with TTL levels
- BiCMOS high speed and output drive
- Output capability: +64 mA/-32 mA
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- Power-up 3-state
- Power-up reset
- No bus current loading when output is tied to 5 V bus
- I_{OFF} circuitry provides partial Power-down mode operation
- Latch-up performance exceeds 500 mA per JESD 78 Class II Level B
- Complies with JEDEC standards
  - JESD8C (2.7 V to 3.6 V)
- ESD protection:
  - HBM: JESD22-A114F exceeds 2000 V
  - MM: JESD22-A115-A exceeds 200 V

3. Ordering information

Table 1. Ordering information

Type number	Package			
	Temperature range	Name	Description	Version
74LVT16543ADGG	-40 °C to +85 °C	TSSOP56	plastic thin shrink small outline package; 56 leads; body width 6.1 mm	SOT364-1

nexperia

4. Functional diagram

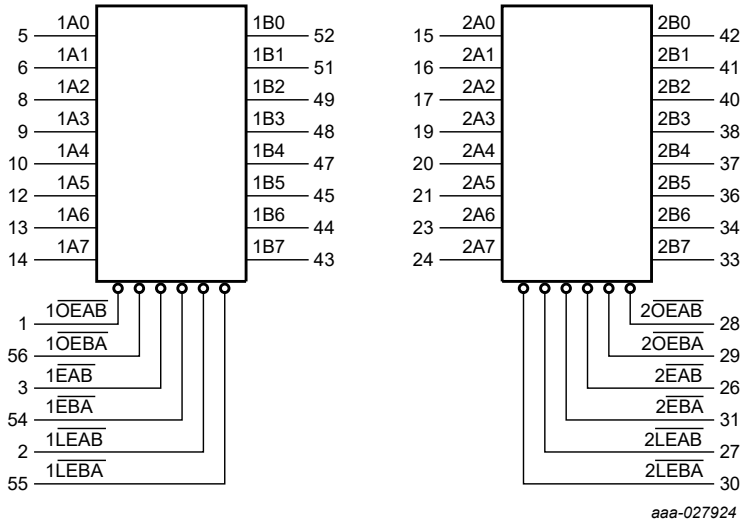


Fig. 1. Logic symbol

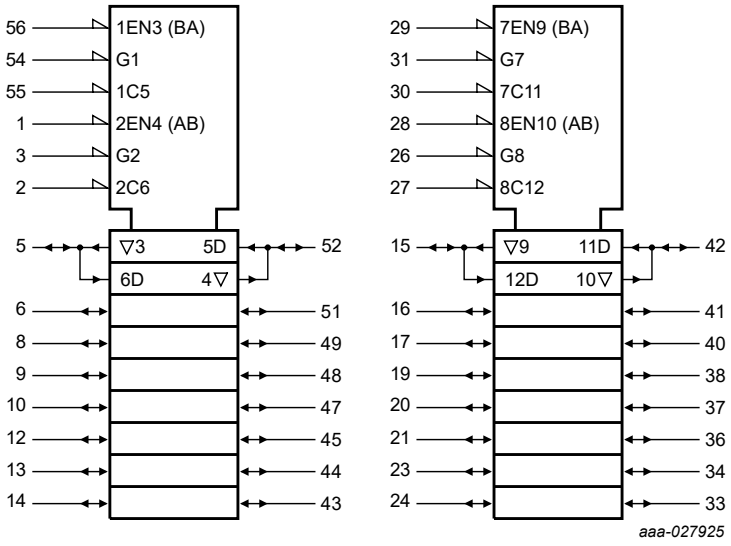


Fig. 2. IEC logic symbol

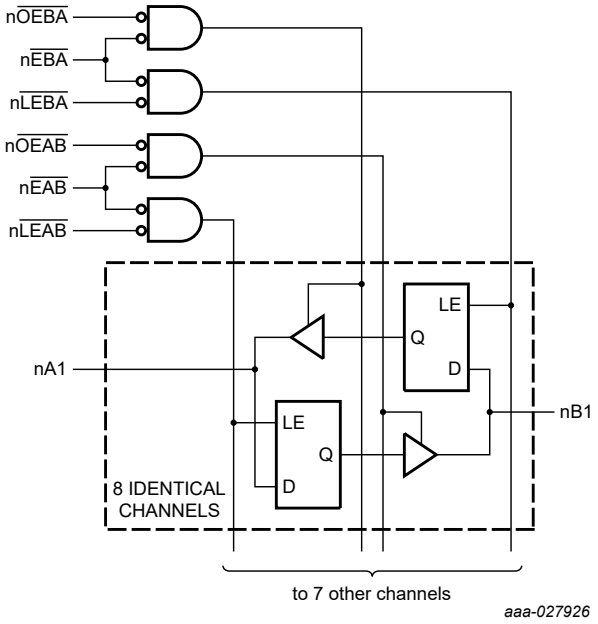


Fig. 3. Logic diagram

5. Pinning information

5.1. Pinning

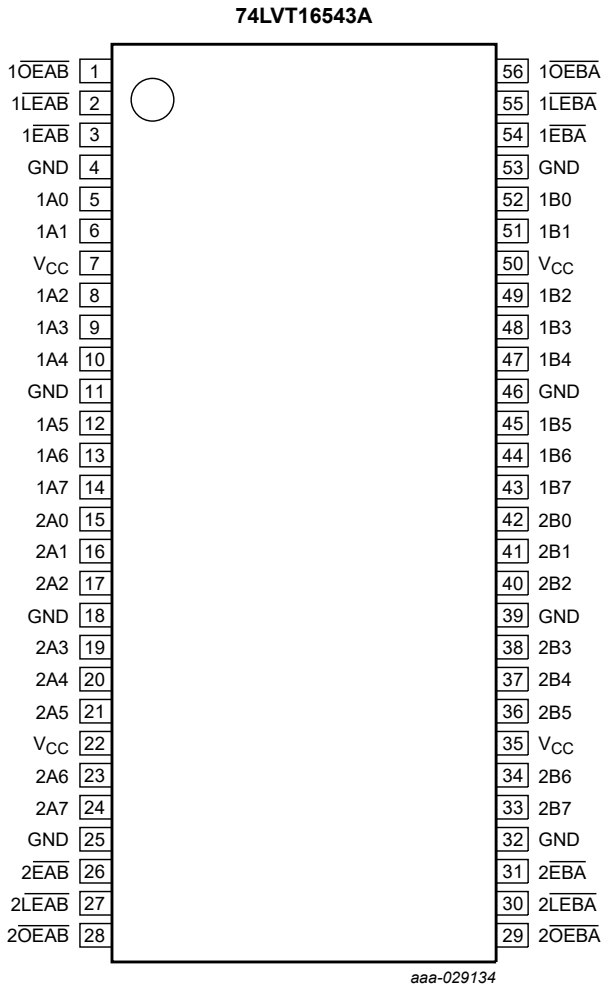


Fig. 4. Pin configuration SOT364-1 (TSSOP56)

5.2. Pin description

Table 2. Pin description

Symbol	Pin	Description
1A0, 1A1, 1A2, 1A3, 1A4, 1A5, 1A6, 1A7	5, 6, 8, 9, 10, 12, 13, 14	data inputs/outputs
2A0, 2A1, 2A2, 2A3, 2A4, 2A5, 2A6, 2A7	15, 16, 17, 19, 20, 21, 23, 24	data inputs/outputs
1B0, 1B1, 1B2, 1B3, 1B4, 1B5, 1B6, 1B7	52, 51, 49, 48, 47, 45, 44, 43	data inputs/outputs
2B0, 2B1, 2B2, 2B3, 2B4, 2B5, 2B6, 2B7	42, 41, 40, 38, 37, 36, 34, 33	data inputs/outputs
1$\overline{OEAB}$, 1$\overline{OEBA}$, 2$\overline{OEAB}$, 2$\overline{OEBA}$	1, 56, 28, 29	A to B / B to A output enable inputs (active LOW)
1$\overline{EAB}$, 1$\overline{EBA}$, 2$\overline{EAB}$, 2$\overline{EBA}$	3, 54, 26, 31	A to B / B to A enable inputs (active LOW)
1$\overline{LEAB}$, 1$\overline{LEBA}$, 2$\overline{LEAB}$, 2$\overline{LEBA}$	2, 55, 27, 30	A to B / B to A latch enable inputs (active LOW)
GND	4, 11, 18, 25, 32, 39, 46, 53	ground (0 V)
V_{CC}	7, 22, 35, 50	supply voltage

6. Functional description

Table 3. Function selection

H = HIGH voltage level;

h = HIGH voltage level one set-up time prior to the LOW-to-HIGH transition of n$\overline{LEAB}$, n$\overline{LEBA}$, n$\overline{EAB}$ and n$\overline{EBA}$;

L = LOW voltage level;

l = LOW voltage level one set-up time prior to the LOW-to-HIGH transition of n$\overline{LEAB}$, n$\overline{LEBA}$, n$\overline{EAB}$ and n$\overline{EBA}$;

↑ = LOW-to-HIGH transition of n$\overline{LEAB}$, n$\overline{LEBA}$, n$\overline{EAB}$ or n$\overline{EBA}$;

X = don't care; NC = no change; Z = high-impedance OFF-state.

Inputs				Outputs	Status
nOEAB or nOEBA	**nEAB or nEBA**	**nLEAB or nLEBA**	**nAn or nBn**	**nBn or nAn**	
H	X	X	X	Z	Disabled
X	H	X	X	Z	Disabled
L	↑	L	h	Z	Disabled + Latch
L	↑	L	l	Z	Disabled + Latch
L	L	↑	h	H	Latch + Display
L	L	↑	l	L	Latch + Display
L	L	L	H	H	Transparent
L	L	L	L	L	Transparent
L	L	H	X	NC	Hold

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		-0.5	+4.6	V
V_I	input voltage	[1]	-0.5	+7.0	V
V_O	output voltage	output in OFF or HIGH state [1]	-0.5	+7.0	V
I_{IK}	input clamping current	$V_I < 0$	-50	-	mA
I_{OK}	output clamping current	$V_O < 0$	-50	-	mA
I_O	output current	output in LOW state	-	128	mA
		output in HIGH state	-64	-	mA
T_{stg}	storage temperature		-65	+150	°C
T_j	junction temperature	[2]	-	+150	°C

[1] The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.
[2] The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability.

8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CC}	supply voltage		2.7	3.6	V
V_I	input voltage		0	5.5	V
T_{amb}	ambient temperature	in free air	-40	+85	°C
$\Delta t/\Delta V$	input transition rise and fall rate	outputs enabled	-	10	ns/V

9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ [1]	Max	Unit
V_{IK}	input clamping voltage	V_{CC} = 2.7 V; I_{IK} = -18 mA	-	-0.85	-1.2	V
V_{IH}	HIGH-level input voltage		2.0	-	-	V
V_{IL}	LOW-level input voltage		-	-	0.8	V
V_{OH}	HIGH-level output voltage	V_{CC} = 2.7 V to 3.6 V; I_{OH} = -100 µA	V_{CC} - 0.2	V_{CC}	-	V
		V_{CC} = 2.7 V; I_{OH} = -8 mA	2.4	2.54	-	V
		V_{CC} = 3.0 V; I_{OH} = -32 mA	2.0	2.36	-	V
V_{OL}	LOW-level output voltage	V_{CC} = 2.7 V; I_{OL} = 100 µA	-	0.07	0.2	V
		V_{CC} = 2.7 V; I_{OL} = 24 mA	-	0.3	0.5	V
		V_{CC} = 3.0 V; I_{OL} = 16 mA	-	0.2	0.4	V
		V_{CC} = 3.0 V; I_{OL} = 32 mA	-	0.3	0.5	V
		V_{CC} = 3.0 V; I_{OL} = 64 mA	-	0.35	0.55	V
I_{OH}	HIGH-level output current		-	-	-32	mA

Symbol	Parameter	Conditions	Min	Typ [1]	Max	Unit
I_{OL}	LOW-level output current		-	-	32	mA
		current duty cycle ≤ 50 %; f_i ≥ 1 kHz	-	-	64	mA
$V_{OL(pu)}$	power-up LOW-level output voltage	V_{CC} = 3.6 V; I_O = 1 mA; V_I = V_{CC} or GND [2]	-	0.13	0.55	V
I_I	input leakage current	control pins				
		V_{CC} = 0 V or 3.6 V; V_I = 5.5 V	-	0.1	10	µA
		V_{CC} = 3.6 V; V_I = V_{CC} or GND	-	0.1	±1	µA
		I/O data pins [3]				
		V_{CC} = 3.6 V; V_I = 5.5 V	-	0.5	20	µA
		V_{CC} = 3.6 V; V_I = V_{CC}	-	0.5	10	µA
		V_{CC} = 3.6 V; V_I = 0 V	-	1	-5	µA
I_{OFF}	power-off leakage current	V_{CC} = 0 V; V_I or V_O = 0 V to 4.5 V	-	1	±100	µA
I_{BHL}	bus hold LOW current	V_{CC} = 3.0 V; V_I = 0.8 V	75	130	-	µA
I_{BHH}	bus hold HIGH current	V_{CC} = 3.0 V; V_I = 2.0 V	-75	-140	-	µA
I_{BHLO}	bus hold LOW overdrive current	V_{CC} = 3.6 V; V_I = 0 V to 3.6 V [4]	500	-	-	µA
I_{BHHO}	bus hold HIGH overdrive current	V_{CC} = 3.6 V; V_I = 0 V to 3.6 V [4]	-	-	-500	µA
I_{CEX}	output high leakage current	output in HIGH-state when V_O > V_{CC}; V_O = 5.5 V; V_{CC} = 3.0 V	-	45	125	µA
$I_{O(pu/pd)}$	power-up/power-down output current	V_{CC} ≤ 1.2 V; V_O = 0.5 V to V_{CC}; V_I = GND or V_{CC}; $n\overline{OE}$ = don't care [5]	-	35	±100	µA
I_{CC}	supply current	V_{CC} = 3.6 V; V_I = V_{CC} or GND; I_O = 0 A				
		outputs HIGH	-	0.07	0.12	mA
		outputs LOW	-	4.5	6	mA
		outputs disabled [6]	-	0.07	0.12	mA
ΔI_{CC}	additional supply current	per input pin; V_{CC} = 3.0 V to 3.6 V; one input = V_{CC} - 0.6 V; other inputs at V_{CC} or GND [7]	-	0.1	0.2	mA
C_I	input capacitance	at control pins; V_I = 0 V or 3.0 V	-	3	-	pF
$C_{I/O}$	input/output capacitance	at input/output data pins, outputs disabled; $V_{I/O}$ = 0 V or 3.0 V	-	9	-	pF

[1] All typical values are measured at V_{CC} = 3.3 V and T_{amb} = 25 °C.
[2] For valid test results, data must not be loaded into the latches after applying power.
[3] Unused pins at V_{CC} or GND.
[4] This is the bus hold overdrive current required to force the input to the opposite logic state.
[5] This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 ms.
From V_{CC} = 1.2 V to V_{CC} = 3.0 V to 3.6 V a transition time of 100 µs is permitted. This parameter is valid for T_{amb} = +25 °C only.
[6] I_{CC} with the outputs disabled is measured with outputs pulled to V_{CC} or GND.
[7] This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND.

10. Dynamic characteristics

Table 7. Dynamic characteristics

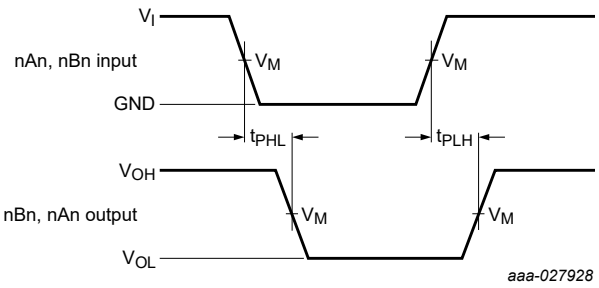
At recommended operating conditions. Voltages are referenced to GND (ground = 0 V). For test circuit see Fig. 9.

Symbol	Parameter	Conditions	Min	Typ [1]	Max	Unit
t_{pd}	propagation delay	nAn to nBn or nBn to nAn; see Fig. 5 [2]				
		V_{CC} = 2.7 V	-	-	4.4	ns
		V_{CC} = 3.3 V ± 0.3 V	1.0	2.2	3.7	ns
t_{pd}	propagation delay	n$\overline{LEBA}$ to nAn, n$\overline{LEAB}$ to nBn; see Fig. 6 [2]				
		V_{CC} = 2.7 V	-	-	6.2	ns
		V_{CC} = 3.3 V ± 0.3 V	1.5	2.7	4.8	ns
t_{PZH}	OFF-state to HIGH propagation delay	n$\overline{OEBA}$ to nAn, n$\overline{OEAB}$ to nBn; see Fig. 7				
		V_{CC} = 2.7 V	-	-	6.1	ns
		V_{CC} = 3.3 V ± 0.3 V	1.5	2.8	4.6	ns
t_{PZL}	OFF-state to LOW propagation delay	n$\overline{OEBA}$ to nAn, n$\overline{OEAB}$ to nBn; see Fig. 7				
		V_{CC} = 2.7 V	-	-	6.6	ns
		V_{CC} = 3.3 V ± 0.3 V	1.5	2.6	5.0	ns
t_{PHZ}	HIGH to OFF-state propagation delay	n$\overline{OEBA}$ to nAn, n$\overline{OEAB}$ to nBn; see Fig. 7				
		V_{CC} = 2.7 V	-	-	5.7	ns
		V_{CC} = 3.3 V ± 0.3 V	2.0	3.1	5.2	ns
t_{PLZ}	LOW to OFF-state propagation delay	n$\overline{OEBA}$ to nAn, n$\overline{OEAB}$ to nBn; see Fig. 7				
		V_{CC} = 2.7 V	-	-	4.7	ns
		V_{CC} = 3.3 V ± 0.3 V	2.0	3.2	4.6	ns
t_{PZH}	OFF-state to HIGH propagation delay	n$\overline{EBA}$ to nAn, n$\overline{EAB}$ to nBn; see Fig. 7				
		V_{CC} = 2.7 V	-	-	6.1	ns
		V_{CC} = 3.3 V ± 0.3 V	1.5	2.9	4.8	ns
t_{PZL}	OFF-state to LOW propagation delay	n$\overline{EBA}$ to nAn, n$\overline{EAB}$ to nBn; see Fig. 7				
		V_{CC} = 2.7 V	-	-	6.6	ns
		V_{CC} = 3.3 V ± 0.3 V	1.5	2.6	5.1	ns
t_{PHZ}	HIGH to OFF-state propagation delay	n$\overline{EBA}$ to nAn, n$\overline{EAB}$ to nBn; see Fig. 7				
		V_{CC} = 2.7 V	-	-	5.7	ns
		V_{CC} = 3.3 V ± 0.3 V	2.0	3.1	5.1	ns
t_{PLZ}	LOW to OFF-state propagation delay	n$\overline{EBA}$ to nAn, n$\overline{EAB}$ to nBn; see Fig. 7				
		V_{CC} = 2.7 V	-	-	4.5	ns
		V_{CC} = 3.3 V ± 0.3 V	2.0	3.2	4.3	ns
$t_{su(H)}$	set-up time HIGH	nAn to n$\overline{LEAB}$, nBn to n$\overline{LEBA}$; see Fig. 8				
		V_{CC} = 2.7 V	0.5	-	-	ns
		V_{CC} = 3.3 V ± 0.3 V	0.8	0.4	-	ns
$t_{su(L)}$	set-up time LOW	nAn to n$\overline{LEAB}$, nBn to n$\overline{LEBA}$; see Fig. 8				
		V_{CC} = 2.7 V	1.5	-	-	ns
		V_{CC} = 3.3 V ± 0.3 V	1.0	0.1	-	ns
$t_{h(H)}$	hold time HIGH	nAn to n$\overline{LEAB}$, nBn to n$\overline{LEBA}$; see Fig. 8				
		V_{CC} = 2.7 V	0.5	-	-	ns
		V_{CC} = 3.3 V ± 0.3 V	1.0	0.2	-	ns

Symbol	Parameter	Conditions	Min	Typ [1]	Max	Unit
$t_{h(L)}$	hold time LOW	nAn to n$\overline{LEAB}$, nBn to n$\overline{LEBA}$; see Fig. 8				
		V_{CC} = 2.7 V	1.3	-	-	ns
		V_{CC} = 3.3 V ± 0.3 V	1.2	0.4	-	ns
$t_{su(H)}$	set-up time HIGH	nAn to n$\overline{EAB}$, nBn to n$\overline{EBA}$; see Fig. 8				
		V_{CC} = 2.7 V	0.4	-	-	ns
		V_{CC} = 3.3 V ± 0.3 V	0.7	0.1	-	ns
$t_{su(L)}$	set-up time LOW	nAn to n$\overline{EAB}$, nBn to n$\overline{EBA}$; see Fig. 8				
		V_{CC} = 2.7 V	1.5	-	-	ns
		V_{CC} = 3.3 V ± 0.3 V	1.3	0.1	-	ns
$t_{h(H)}$	hold time HIGH	nAn to n$\overline{EAB}$, nBn to n$\overline{EBA}$; see Fig. 8				
		V_{CC} = 2.7 V	0.8	-	-	ns
		V_{CC} = 3.3 V ± 0.3 V	1.2	0.2	-	ns
$t_{h(L)}$	hold time LOW	nAn to n$\overline{EAB}$, nBn to n$\overline{EBA}$; see Fig. 8				
		V_{CC} = 2.7 V	1.4	-	-	ns
		V_{CC} = 3.3 V ± 0.3 V	1.3	0.4	-	ns
t_{WL}	pulse width LOW	n$\overline{LEAB}$ and n$\overline{LEBA}$; see Fig. 6				
		V_{CC} = 2.7 V	1.8	-	-	ns
		V_{CC} = 3.3 V ± 0.3 V	1.8	1.0	-	ns

[1] Typical values are measured at T_{amb} = 25 °C and V_{CC} = 3.3 V
[2] t_{pd} is the same as t_{PLH} and t_{PHL}

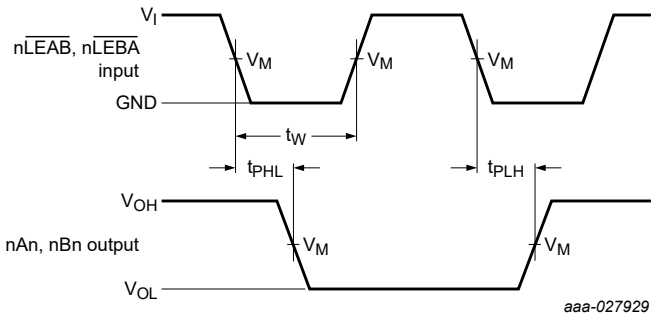
10.1. Waveforms and test circuit



See Table 8 for measurement points.

V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

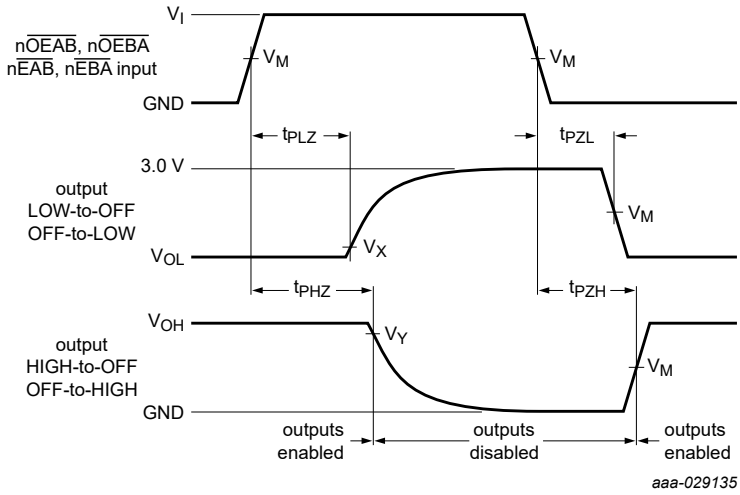
Fig. 5. Input (nAn, nBn) to output (nBn, nAn) propagation delays



See Table 8 for measurement points.

V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

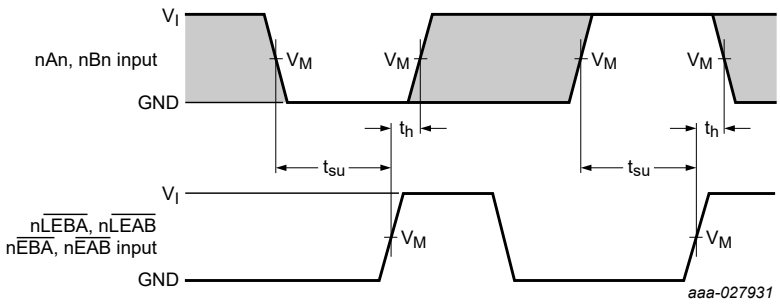
Fig. 6. Input (nLEAB, nLEBA) to output (nBn, nAn) propagation delays and pulse width LOW



See Table 8 for measurement points.

V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

Fig. 7. 3-state output enable and disable times



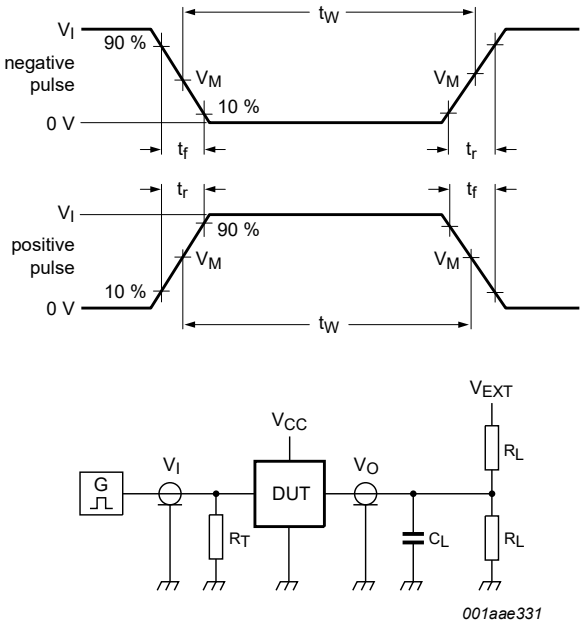
See Table 8 for measurement points.

The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig. 8. Data set-up and hold times for the inputs nAn and nBn to nLEBA, nLEAB, nEBA and nEAB inputs

Table 8. Measurement points

Input		Output		
V_I	**V_M**	**V_M**	**V_x**	**V_y**
2.7 V	1.5 V	1.5 V	V_{OL} + 0.3 V	V_{OH} - 0.3 V



Test data is given in Table 9.

Definitions test circuit:

R_L = Load resistance;

C_L = Load capacitance including jig and probe capacitance;

R_T = Termination resistance should be equal to output impedance Z_o of the pulse generator;

V_{EXT} = External voltage for measuring switching times.

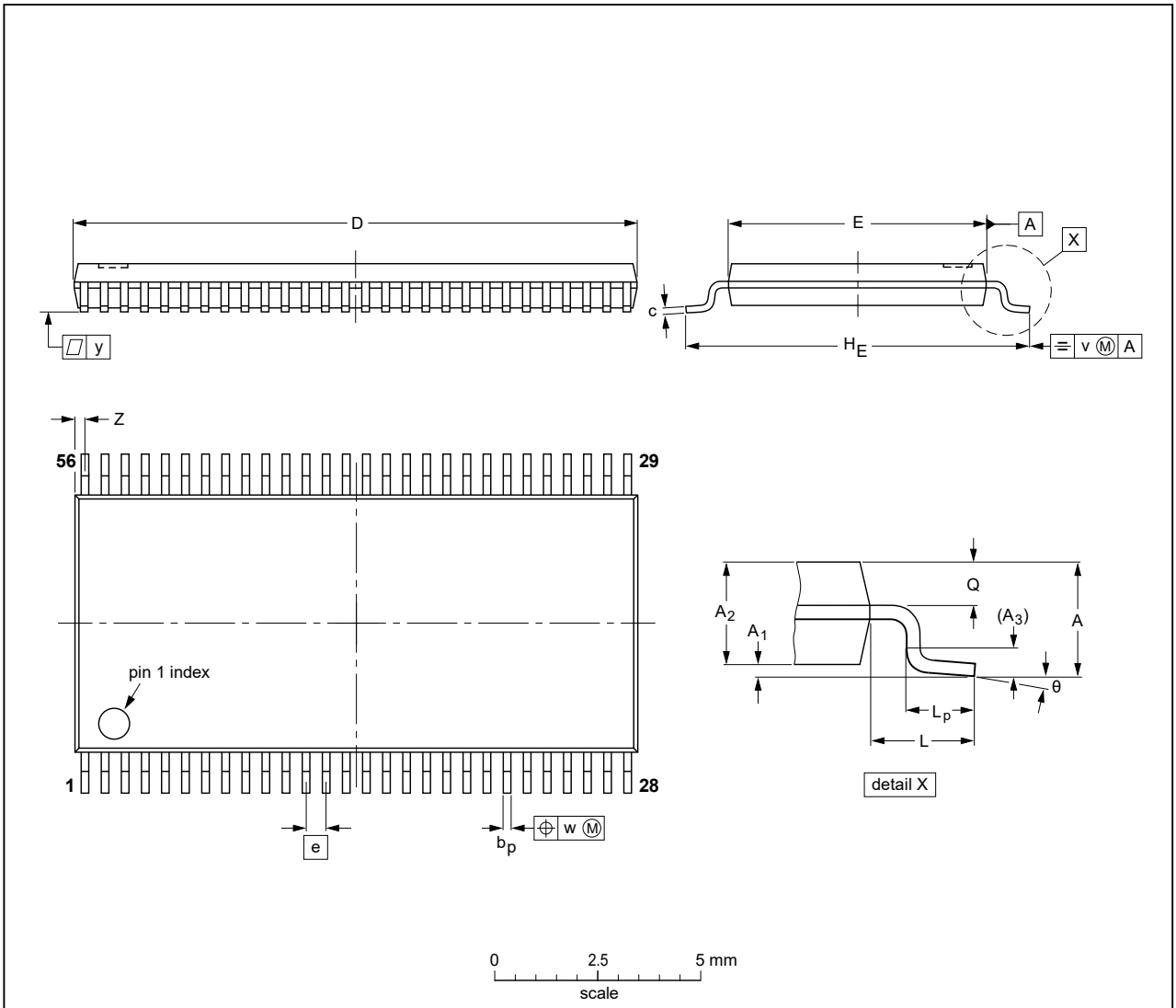
Fig. 9. Test circuit for measuring switching times

Table 9. Test data

Input				Load		V_{EXT}		
V_I	f_i	t_W	t_r, t_f	R_L	C_L	t_{PHZ}, t_{PZH}	t_{PLZ}, t_{PZL}	t_{PLH}, t_{PHL}
2.7 V	≤ 10 MHz	500 ns	≤ 2.5 ns	500 Ω	50 pF	GND	6 V	open

11. Package outline

TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1 mm **SOT364-1**



DIMENSIONS (mm are the original dimensions).

UNIT	A max.	A_1	A_2	A_3	b_p	c	D(1)	E(2)	e	H_E	L	L_p	Q	v	w	y	Z	θ
mm	1.2	0.15 0.05	1.05 0.85	0.25	0.28 0.17	**0.2** **0.1**	14.1 13.9	6.2 6.0	0.5	8.3 7.9	1	0.8 0.4	0.50 0.35	0.25	0.08	0.1	0.5 0.1	8° 0°

Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT364-1		MO-153				~~99-12-27~~ 03-02-19

Fig. 10. Package outline SOT364-1 (TSSOP56)

12. Abbreviations

Table 10. Abbreviations

Acronym	Description
BiCMOS	Bipolar Complementary Metal Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
MM	Machine Model
TTL	Transistor-Transistor Logic

13. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74LVT16543A v.4	20210401	Product data sheet	-	74LVT16543A v.3
Modifications:	• Section 1 and Section 2 updated. • Type number 74LVT16543ADL (SOT371-1 / SSOP56) removed.			
74LVT16543A v.3	20181001	Product data sheet	-	74LVT16543A v.2
Modifications:	• The format of this data sheet has been redesigned to comply with the identity guidelines of Nexperia. • Legal texts have been adapted to the new company name where appropriate.			
74LVT16543A v.2	19980219	Product specification	-	74LVT16543A v.1
74LVT16543A v.1	-	Product specification		-

14. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.
[2] The term 'short data sheet' is explained in section "Definitions".
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